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Sheet 1 of 1

U.S. Department of Commerce, Patent and Trademark Office		Attorney Docket No.	Serial No.
		DC-05164	10/657,989
INFORMATION DISCLOSURE STATEMENT BY APPLICANT		Applicant(s)	
(Use several sheets if necessary)		Shree Dandekar et al.	
		Filing Date	Group
		September 9, 2003	2123

U.S. Patent Documents

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents

							Translation	
		Document	Date	Country	Class	Subclass	Yes	No
	AL						<input type="checkbox"/>	<input type="checkbox"/>
	AM						<input type="checkbox"/>	<input type="checkbox"/>
	AN						<input type="checkbox"/>	<input type="checkbox"/>
	AO						<input type="checkbox"/>	<input type="checkbox"/>
	AP						<input type="checkbox"/>	<input type="checkbox"/>

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

QC	AR	Johnson, Raul, et al., U.S. Patent Publication No. US 2004/0073890A1, published April 15, 2004, entitled "Method and System for Test Management," Serial No. 10/267,513, filed October 9, 2002
QC	AS	Eden, Matthew, et al., U.S. Patent Application entitled "Method and System for Information Handling System Automated and Distributed Test," Serial No. 10/614,762, filed July 7, 2003
QC	AT	Wong, et al., U.S. Patent Publication No. US 2002/0104042A1, published August 1, 2002, entitled "Automated Test System and Method for Computer Factory Install Environment," Serial No. 09/770,565, filed January 26, 2001

Examiner /Qing Chen/ Date Considered 09/18/2006

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.